The Structure of La₂₆(BO₃)₈O₂₇: A Structure with a Distorted Fluorite Type Arrangement of Atoms

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Very small colorless crystals of La₂₆(BO₃)₈O₂₇ were grown from La₂O₃ and H₃BO₃. The composition found by the structure determination corresponds to La₃BO₆ with a slight excess of La₂O₃. La₂₆(BO₃)₈O₂₇ crystallizes in the monoclinic space group $P2_1/c$ with the lattice constants a = 692.0(1) pm, b = 1292.3(1)pm, c = 1457.1(1) pm, and $\beta = 99.41(1)^\circ$. Its structure consists of fluorite slabs in which the lanthanum atoms have a cubic coordination and lanthanum atoms in a square antiprismatic coordination. This square antiprismatic polyhedra are connected by the borate groups. © 1996 Academic Press, Inc.

1. INTRODUCTION

It has been known that three binary compounds exist in the $B_2O_3-La_2O_3$ system, $LaBO_3$, LaB_3O_6 , and $(LaO)_3BO_3$ (1, 2). Among these compounds, the crystal structures of $LaBO_3$ and LaB_3O_6 are well established, though the structural characterization of these compounds was complicated by their polymorphic nature (3). For the structure of $(LaO)_3BO_3$ little was known from the pioneer investigations by S. F. Bartram in the 1960s (2). Bartram has determined the space groups of $(LnO)_3BO_3$ (Ln = Lato Lu) by Weissenberg techniques and refined the lattice constants from X-ray powder diffraction patterns. These compounds crystallize with unit cells in two different monoclinic space groups, i.e., $P2_1/c$ for Ln = La to Nd, C2/m (C2, Cm) with Z = 6 for Ln = Pm to Yb, and C2/m with Z = 8 for Ln = Lu.

Recently, considerable interest for these compounds was stimulated by the potential application as the hosts of luminescent materials (4, 5). We now report a single-crystal study on $(LaO)_3BO_3$ in which we found that the actual composition is not $(LaO)_3BO_3$ but instead $La_{26}(BO_3)_8O_{27}$.

2. EXPERIMENTAL

Polycrystalline samples of the rare earth borate La₂₆ (BO₃)₈O₂₇ were prepared by using stoichiometric amounts of La₂O₃ of over 99.99% purity and analytical grade H₃BO₃ as starting materials. After preheating at 850°C for 6 h, these samples were ground and reheated from 1250 to 1350°C for 12 h in air or in a crucible covered with graphite powder. The samples were confirmed to be pure by X-ray powder diffraction. The measurements were carried out on a Rigaku D/MAX-2000 diffractometer using CuK α radiation from a rotational anode. Colorless single crystals of La₂₆(BO₃)₈O₂₇ were grown by annealing in an alumina crucible on air at 1350°C.

3. STRUCTURE DETERMINATION

The structure determination of La₂₆(BO₃)₈O₂₇ was performed on several single crystals of La₂₆(BO₃)₈O₂₇. A very small single crystal was examined by BUERGER precession techniques at room temperature. From the photographs the monoclinic space group $P2_1/c$ was derived with the same lattice constants for the unit cell as observed in the diffractometer measurement a = 692.0(1) pm, b =1292.3(1) pm, c = 1457.1(1) pm, and $\beta = 99.41(1)^\circ$. Even on overexposed films (40 h) no superstructure was observed. One crystal (0.24 × 0.18 × 0.1 mm) was examined on a SIEMENS P4 diffractometer with a graphite monochromator using MoK α ($\lambda = 71,073$ pm) radiation and a

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 ω -scan in a Θ -range between 4.08° and 26°. The data were corrected for Lorentz and polarization effects. After sorting and merging, 2497 reflections were used to refine 122 parameters. The structure was solved using direct methods and full matrix least squares on $F^2(7, 8)$. A Ψ -scan absorption correction was applied to the data. At an R-value of 11.5% the metal atoms have been refined with anisotropic temperature factors. Because of strong absorption effects only isotropic temperature factors could be refined for the oxygen atoms. However, the isotropic temperature factor of O(13) was rather high which indicated a lower occupancy for O(13) on this site. With a site occupation factor of 0.75 the temperature factor becomes normal with a value of $U_{eq} = 8(2)$ for O(13). This corresponds to a composition $La_{26}(BO_3)_8O_{27}$ which is required for charge neutrality. From the structure determination we have no indication for an OH^- group on this O(13) position. The final Rvalue was R = 0.0418 (for $I > 2\sigma I$) (9). Parameters are given in Tables 1–3.

4. RESULTS AND DISCUSSION

The asymmetric unit of La₂₆(BO₃)₈O₂₇ consists of seven lanthanum atoms of which La(1) is on the special Wyckoff position 2b while the others are on the general position 4e. Thirteen oxygen atoms and two boron atoms are on the general position 4e. The asymmetric unit contains two crystallographically independent BO₃³⁻ groups. Both borate groups consist of a boron atom triangularly coordinated by oxygen atoms; bond distances B-O are at a mean value of 137 pm (Table 4). This is a little smaller than the sum of the covalent radii (148 pm) but about the mean value for such a triangularly coordinated boron (10). All angles are close to 120°. Three different sets of La-O distances are observed, La-O distances with a mean value of 245 pm, distances with a mean value of 263 pm for the oxygen atoms belonging to a borate group, and distances between 275 and 295 pm where the oxygen atoms can still be considered in the coordination sphere of lanthanum.

The lanthanum atoms occupy different coordination polyhedra. La(1), La(4), and La(6) are in a cubic coordination. La(1) is coordinated by two borate groups occupying four corners of the cube and four O^{2-} ions (Table 4). La(4) is coordinated by one borate group occupying two corners of the cube and 6 O^{2-} ions, and La(6) is coordinated by three BO_3^{3-} groups on five corners of a rather distorted cube and three O^{2-} ions. La(2) and La(3) are in a sevencoordinated environment. The seven corners of the coordination polyhedra are occupied by five O^{2-} ions and one oxygen atom of each of the two coordinating borate groups. Such coordination polyhedra are known from the Baddeleyite type structure in ZrO_2 . La(5) has a quadratic antiprismatic coordination with four oxygens belonging to borate groups and 4 O^{2-} ions (Fig. 1). La(7) is also seven

 TABLE 1

 Crystal Data and Structure Refinement for La₂₆(BO₃)₈O₂₇

Formula weight4514.16Crystal systemMonoclinicSpace group $P2_1/c$ (No. 14)Unit cell dimensions $a = 692.0(1)$ pm, $\alpha = 90^{\circ}$ $b = 1292.3(1)$ pm, $\beta = 99.41(1)^{\circ}$ $c = 1457.1(1)$ pm, $\gamma = 90^{\circ}$ Volume1.2855(2) nm ³ Z 1Temperature293(2) KRadiationMoK α ($\lambda = 71.073$ pm)Density (calculated)5.831 Mg/m ³ Absorption coefficient21.168 mm ⁻¹ $F(000)$ 1930Color, habitColorless blockCrystal size0.24 × 0.18 × 0.1 mm θ range for data collection4.08 to 26.00°Index ranges $-3 \le h \le 8, -1 \le k \le 15, -17 \le l \le 17$ Reflections collected3713Independent reflections2508 ($R_{init} = 0.0427$)Reflections with $I > 2\sigma(I)$ 2024Absorption correction ψ -scanMax. and min. transmission0.388 and 0.138Refinement methodFull-matrix least-squares on F^2 Data/restraints/parameters2497/0/122Goodness-of-fit on F^2 1.066Final R indices $[I > 2\sigma(I)]$ R1 = 0.418, wR2 = 0.0978R indices (all data)R1 = 0.0589, wR2 = 0.1192Extinction coefficient0.00194(11)Largest diff. peak and hole2630 and $-2934 e$ nm ⁻³ Data collectionSiemens P4MonochromatorHighly oriented graphite crystalScan type ω Scan range (ω)0.8°Standard reflections3 measured every 100 reflectionsSolution	Molecular formula	$B_8La_{26}O_{51}$				
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Solution Direct methods Weighting scheme $Calc w = 1/[\sigma^2(Fo^2) + (0.0510P)^2 + 16.7349P]$ where $P = (F_o^2 + 2F_o^2)/3$		SHELXL-93 (Sheldrick, 1993)				
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$+ 16.7349P$] where $P = (F_0^2 + 2F_c^2)/3$	Weighting scheme	Calc $w = 1/[\sigma^2(Fo^2) + (0.0510P)^2]$				
		+ 16.7349 <i>P</i>] where $P = (F_o^2 + 2F_c^2)/3$				

coordinated, i.e., one borate group occupying two corners, two borate groups occupying one corner each, and three O^{2-} ions on the remaining corner. The bond valence sums for the lanthanum atoms and the oxygen atoms are as expected.

A close inspection of this structure reveals a certain relationship to the (CaF₂) fluorite structure, both from the structure and the composition point of view. At first sight, neglecting the boron atoms in the structure, the composition will be close to "LaO₂" (<u>La₂₆O_{52-x}B₈</u>). Furthermore the structure of La₂₆(BO₃)₈O₂₇ can be considered as a

La(7)-O(3)

La(7) - O(6)

La(7)-O(4)

La(7)-O(2)

TABLE 2Atomic Coordinates and Equivalent Isotropic DisplacementParameters ($pm^2 \times 10^{-1}$) for La₂₆(BO₃)₈O₂₇

	-			
	x	у	z	U(eq)
La(1)	0.0000	0.0000	0.0000	8(1)
La(2)	0.5149(1)	0.1099(1)	0.0873(1)	9(1)
La(3)	0.1518(1)	0.1942(1)	0.4691(1)	10(1)
La(4)	0.6841(1)	0.3854(1)	0.0603(1)	13(1)
La(5)	0.6251(1)	0.3004(1)	0.3402(1)	9(1)
La(6)	0.2308(1)	0.5023(1)	0.1718(1)	15(1)
La(7)	0.0602(1)	0.2129(1)	0.2022(1)	11(1)
O(1)	0.0088(14)	0.8507(7)	0.1306(6)	14(2)
O(2)	0.1586(14)	0.5093(7)	0.3473(6)	13(2)
O(3)	0.2673(15)	0.3497(7)	0.2930(6)	17(2)
O(4)	0.4266(14)	0.1320(7)	0.2586(6)	13(2)
O(5)	0.5940(17)	0.4545(8)	0.2119(7)	25(2)
O(6)	0.1623(15)	0.0676(8)	0.3268(6)	19(2)
O(7)	0.1641(13)	0.1539(7)	0.0693(6)	11(2)
O(8)	0.3424(14)	0.5545(7)	0.5477(6)	12(2)
O(9)	0.7306(15)	0.2367(7)	0.1816(7)	17(2)
O(10)	0.0366(14)	0.3630(8)	0.1061(6)	16(2)
O(11)	0.4843(15)	0.2483(7)	0.4813(6)	17(2)
O(12)	0.1871(14)	0.6544(7)	0.0893(6)	13(2)
O(13)	0.3452(17)	0.4553(9)	0.0341(7)	8(2)
B(1)	0.1349(22)	0.4007(11)	0.3367(9)	9(3)
B(2)	0.3296(23)	0.0513(12)	0.2903(10)	13(3)

Note. U(eq) is defined as one third of the trace of the orthogonalized U_{ii} tensor.

distorted version of the fluorite structure. To emphasize this feature one of the "fluorite" layers with a stacking sequence O-La-O is presented in Fig. 2. The sheets are oriented perpendicular to the [101] lattice direction (Fig. 3).

The characteristics of a CaF_2 structure are anion cubes of which every second is occupied by a metal atom. In Fig. 2a one sees that La(1), La(4), and La(6) have such a cubic coordination. La(2), La(3), and La(7) have a sevenfold coordination caused by the distortion around La(5).

TABLE 3 Anisotropic Displacement Parameters (pm² × 10⁻¹) for La₂₆(BO₃)₈O₂₇

	U_{11}	U_{22}	U_{33}	U_{23}	U_{13}	U_{12}
La(1)	5(1)	7(1)	14(1)	-1(1)	2(1)	-1(1)
La(2)	4(1)	8(1)	13(1)	0(1)	0(1)	1(1)
La(3)	5(1)	11(1)	14(1)	4(1)	2(1)	2(1)
La(4)	10(1)	12(1)	18(1)	-4(1)	2(1)	-2(1)
La(5)	3(1)	9(1)	16(1)	-1(1)	1(1)	-1(1)
La(6)	11(1)	14(1)	19(1)	7(1)	-3(1)	-4(1)
La(7)	7(1)	13(1)	13(1)	0(1)	1(1)	2(1)

Note. The anisotropic displacement factor exponent takes the form $-2\pi^2 [(ha^*)^2 U_{11} + \cdots + 2hka^*b^*U_{12}].$

Interatomic Distances in La₂₆(BO₃)₈O₂₇ Given in pm La(1) - O(7)242.7(9) La(2) - O(11)238.3(9) La(1)-O(7) 242.7(9) La(2) - O(8)244.8(8) 245.9(9) La(1) - O(8)246.0(9) La(2) - O(8)246.0(9) 246.5(9) La(1) - O(8)La(2) - O(7)263.9(8) La(1) - O(2)La(2) - O(9)247.6(10) La(1) - O(2)263.9(8) La(2) - O(2)264.6(10) La(1) - O(1)270.4(9) La(2) - O(4)268.0(8)La(1) - O(1)270.4(9) 238.3(10) 238.8(10) La(3) - O(11)La(4) - O(11)La(3) - O(10)238.5(9) La(4) - O(10)243.8(10) La(3) - O(12)241.6(10) La(4)-O(13) 246.6(11) La(3) - O(7)244.0(9)La(4)-O(13) 248.3(12)254.0(8) La(3) - O(13)245.0(12) La(4) - O(12)La(3) - O(1)262.8(9) La(4) - O(5)255.2(10) La(3) - O(6)265.2(9) La(4) - O(9)259.5(10) La(4) - O(6)296.7(10) 242.2(9) 229.8(9)La(5) - O(12)La(6) - O(12)247.3(9) La(5) - O(8)La(6)-O(10) 235.4(10) La(5)-O(11) 250.6(9) La(6)-O(13) 235.5(10) La(5) - O(3)254.1(10) La(6) - O(5)256.1(11) La(5) - O(1)258.2(10) La(6)-O(3) 263.1(9) La(6)-O(2) La(5) - O(9)266.5(9) 268.6(8)La(5) - O(5)271.6(11) La(6) - O(6)285.1(10) La(5) - O(4)273.9(9) La(6) - O(4)294.5(9) La(7) - O(9)227.2(10) O(1) - B(1)134(2)La(7) - O(7)230.3(8) O(2) - B(1)142(2)La(7)-O(10) 238.2(9) O(3) - B(1)137(2)

TABLE 4

The fact that all of the BO_3^{3-} groups in the structure locate within the distorted block around the La(5) atom is an evidence that the deviation from the fluorite geometry is mainly due to the short B–O bond distance required in

251.1(10)

262.8(10)

274.2(9)

304.7(9)

O(4) - B(2)

O(5) - B(2)

O(6) - B(2)

136(2)

136(2)

137(2)

FIG. 1. The square antiprismatic coordination of La(5) by four O^{2-} -ions and four borate groups.





FIG. 2. A cut showing the fluorite related layer and the deviations of La(6) and La(7) from "fluorite" positions. The coordination polyhedra of the lanthanum atoms are shown in both figures close to the [101] direction, in (a) as a bondstick model and in (b) as a polyhedra model.

the BO_3^{3-} groups. In an idealized fluorite structure (Fig. 4) the borate groups fit well on faces of the empty cubes. The structure adopts this by switching one face of the central cube around by 45°. This is exactly the situation around La(5). The transformation of a cube into a square antiprism is a well-known principle in anion excess fluorite related structures forced by an anion excess (11).

Three borate groups are located in the plane of one quadratic face of the square antiprism (Fig. 2). The fourth BO_3^{3-} -group in the coordination of La(5) is in the upper

square face of the square antiprism and cannot be adopted without major distortions in the metal atom lattice by the fluorite structure. This explains the distortion of La(6) and La(7) which are long distance from "normal" fluorite positions. Interestingly the distorted blocks centered with La(5) form a zig-zag chain-like arrangement connected through BO_{3}^{3-} and La(6) and La(7) groups.

In Fig. 4 we tried to reconstruct the distortions from a normal fluorite projection along $[100]_{fluorite}$. The anion cubes have a regular edge length of 1. Then the misfit



FIG. 3. A projection of the unit cell of $La_{26}(BO_3)_8O_{27}$ along [010] shows how the La(5) square antiprisms are connected by BO_3^{3-} groups in the "fluorite"-like layers of the structure.



FIG. 4. An idealized fluorite arrangement of atoms and the effect of filling three of the empty square faces with triangular BO_3^{3-} groups. The fourth BO_3^{3-} group is inserted in the upper face and causes the distortion of La(6) and La(7) (arrows). The numbers in the large circles give the type of La atoms. The filled one is La(5).

between an equilateral triangle with an edge length of unity and the regular position of the corner from the square antiprism is 0.065, which is negligable. For a borate group with a B–O bond length of 137 pm the distance between the oxygen position will be 237.3 pm, which compares rather well to the 238.9 pm found, e.g., for the O(1)-O(2)distance in the coordination of La(1) while the other O–O distances are at a mean value of 295.3 pm.

5. CONCLUSION

Previously La₂₆(BO₃)₈O₂₇ was described as La₃BO₆ with the remark that the samples contain a small amount of unreacted oxide (12). This structure determination shows that the structures of this lanthanide-borate-compound is more complex than expected. One can assume that the other monoclinic compounds with space group $P2_1/c$, i.e., Ln_3BO_6 (Ln = Pr, Nd), are isostructural to the lanthanum compound La₂₆(BO₃)₈O₂₇. However, it will be rather interesting if the partial occupation on the O(13)-site could be filled in the case of the substitution of some of the La³⁺ions by, e.g., Ce⁴⁺-ions and if a La₂₄Ce₂(BO₃)₈O₂₈ could be prepared. The structure also provides a simple suggestion of how, from the structural point of view, defects could be inserted into fluorite structures by simply inserting BO_3^{3-} -groups into the lattice. This can be studied by the coordination of the La(5)-atom in the structure of $La_{26}(BO_3)_8O_{27}$.

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